Product Preview

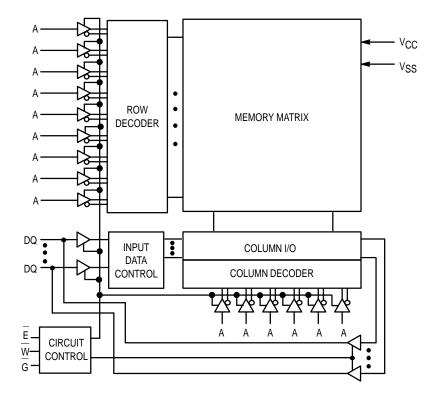
32K x 8 Bit Fast Static RAM

The MCM6206BB is a 262,144 bit static random access memory organized as 32,768 words of 8 bits. Static design eliminates the need for external clocks or timing strobes, while CMOS circuitry reduces power consumption and provides for greater reliability.

This device meets JEDEC standards for functionality and pinout, and is available in plastic small—outline J—leaded packages.

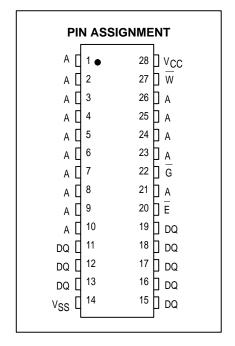
- Single 5 V ± 10% Power Supply
- Fully Static No Clock or Timing Strobes Necessary
- Fast Access Times: 12/15/20/25 ns
- Equal Address and Chip Enable Access Times
- Output Enable (G) Feature for Increased System Flexibility and to Eliminate Bus Contention Problems
- Low Power Operation: 125 140 mA Maximum AC
- Fully TTL Compatible Three State Output

BLOCK DIAGRAM



MCM6206BB





PIN NAMES
A Address Input DQ Data Input/Data Output W Write Enable G Output Enable E Chip Enable VCC Power Supply (+ 5 V) VSS Ground

This document contains information on a product under development. Motorola reserves the right to change or discontinue this product without notice.

6/4/97



TRUTH TABLE (X = Don't Care)

Е	G	W	Mode	V _{CC} Current	Output	Cycle
Н	Х	Х	Not Selected	I _{SB1} , I _{SB2}	High-Z	_
L	Н	Н	Output Disabled	ICCA	High–Z	_
L	L	Н	Read	ICCA	D _{out}	Read Cycle
L	Х	L	Write	ICCA	High–Z	Write Cycle

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Power Supply Voltage	VCC	- 0.5 to + 7.0	V
Voltage Relative to VSS For Any Pin Except VCC	V _{in} , V _{out}	- 0.5 to V _{CC} + 0.5	V
Output Current	l _{out}	± 20	mA
Power Dissipation	PD	1.0	W
Temperature Under Bias	T _{bias}	- 10 to + 85	°C
Ambient Temperature	TA	0 to + 70	°C
Storage Temperature—Plastic	T _{stg}	- 55 to + 125	°C

NOTE: Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPER-ATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to this high-impedance circuit.

This CMOS memory circuit has been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow of at least 500 linear feet per minute is maintained.

DC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{CC} = $5.0 \text{ V} \pm 10\%$, T_A = 0 to 70° C, Unless Otherwise Noted)

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Тур	Max	Unit
Supply Voltage (Operating Voltage Range)	Vcc	4.5	5.0	5.5	V
Input High Voltage	VIH	2.2	1	V _{CC} + 0.3**	V
Input Low Voltage	V _{IL}	- 0.5*	_	0.8	V

^{*} V_{IL} (min) = -0.5 V dc; V_{IL} (min) = -2.0 V ac (pulse width ≤ 20 ns)

DC CHARACTERISTICS

Parameter	Symbol	Min	Max	Unit
Input Leakage Current (All Inputs, V _{in} = 0 to V _{CC})	l _{lkg(l)}	_	± 1	μΑ
Output Leakage Current (E = V _{IH} or G = V _{IH} , V _{Out} = 0 to V _{CC})	I _{lkg(O)}	_	± 1	μΑ
Output High Voltage (I _{OH} = – 4.0 mA)	Voн	2.4	_	V
Output Low Voltage (I _{OL} = 8.0 mA)	V _{OL}		0.4	V

POWER SUPPLY CURRENTS

Parameter	Symbol	- 12	- 15	- 20	- 25	Unit
AC Active Supply Current ($I_{out = 0 \text{ mA}}$, $V_{CC} = Max$, $f = f_{max}$)	ICCA	140	135	130	125	mA
AC Standby Current (E = V _{IH} , V _{CC} = Max, f = f _{max})	I _{SB1}	40	35	35	30	mA
CMOS Standby Current (V $_{CC}$ = Max, f = 0 MHz, E \geq V $_{CC}$ - 0.2 V V $_{in} \leq$ V $_{SS}$ + 0.2 V, or \geq V $_{CC}$ - 0.2 V)	I _{SB2}	10	10	10	10	mA

CAPACITANCE (f = 1 MHz, dV = 3 V, T_A = 25°C, Periodically sampled rather than 100% tested)

Characteristic	Symbol	Max	Unit
Address Input Capacitance	C _{in}	6	pF
Control Pin Input Capacitance (E, G, W)	C _{in}	8	pF
I/O Capacitance	C _{I/O}	8	pF

^{**} V_{IH} (max) = V_{CC} + 0.3 V dc; V_{IH} (max) = V_{CC} + 2.0 V ac (pulse width \leq 20 ns)

AC OPERATING CONDITIONS AND CHARACTERISTICS

 $(V_{CC} = 5.0 \text{ V} \pm 10\%, T_A = 0 \text{ to} + 70^{\circ}\text{C}, \text{ Unless Otherwise Noted})$

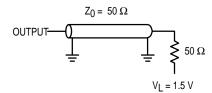
Input Timing Measurement Reference Level 1.5 V	Output Timing Measurement Reference Level 1.5 V
Input Pulse Levels 0 to 3.0 V	Output Load Figure 1 Unless Otherwise Noted
Input Rise/Fall Time 5 ns	

READ CYCLE (See Note 1)

		- 12		– 15		- 20		- 25			
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Read Cycle Time	tavav	12	_	15	_	20	_	25	_	ns	2
Address Access Time	^t AVQV	_	12	_	15	_	20	_	25	ns	
Enable Access Time	t _{ELQV}	_	12	_	15	_	20	_	25	ns	3
Output Enable Access Time	^t GLQV	_	6	_	8	_	10	_	12	ns	
Output Hold from Address Change	tAXQX	3	_	3	_	3	_	3	_	ns	4,5,6
Enable Low to Output Active	^t ELQX	4	_	4	_	4	_	4	_	ns	4,5,6
Enable High to Output High–Z	^t EHQZ	_	7	_	8	_	9	_	10	ns	4,5,6
Output Enable Low to Output Active	^t GLQX	0	_	0	_	0	_	0	_	ns	4,5,6
Output Enable High to Output High–Z	^t GHQZ	_	6	_	7	_	8	_	10	ns	4,5,6
Power Up Time	^t ELICCH	0	_	0	_	0	_	0	_	ns	
Power Down Time	^t EHICCL	_	12	_	15	_	20	_	25	ns	

NOTES:

- 1. W is high for read cycle.
- 2. All timings are referenced from the last valid address to the first transitioning address.
- 3. Addresses valid prior to or coincident with E going low.
- At any given voltage and temperature, t_{EHQZ} (max) is less than t_{ELQX} (min), and t_{GHQZ} (max) is less than t_{GLQX} (min), both for a given device and from device to device.
- 5. Transition is measured ±500 mV from steady-state voltage.
- 6. This parameter is sampled and not 100% tested.
- 7. Device is continuously selected (E = V_{IL}, G = V_{IL}).



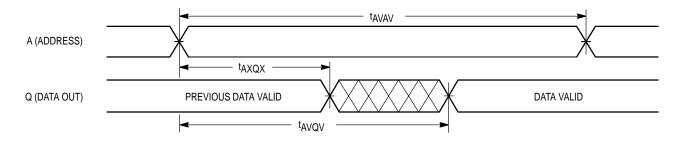
TIMING LIMITS

The table of timing values shows either a minimum or a maximum limit for each parameter. Input requirements are specified from the external system point of view. Thus, address setup time is shown as a minimum since the system must supply at least that much time. On the other hand, responses from the memory are specified from the device point of view. Thus, the access time is shown as a maximum since the device never provides data later than that time.

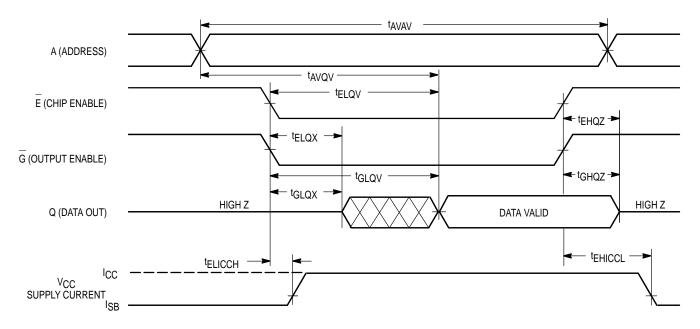
Figure 1. AC Test Loads

MOTOROLA FAST SRAM MCM6206BB

READ CYCLE 1 (See Note 7)



READ CYCLE 2 (See Note 3)



MCM6206BB MOTOROLA FAST SRAM

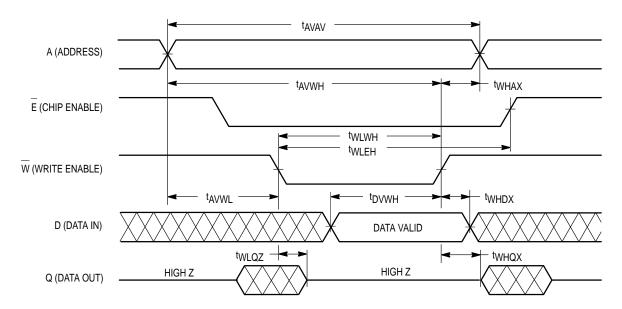
WRITE CYCLE 1 (W Controlled, See Notes 1 and 2)

		_	12	_	15	-	20	- :	25		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	tavav	12	_	15	_	20	_	25	_	ns	3
Address Setup Time	tAVWL	0	_	0	_	0	_	0	_	ns	
Address Valid to End of Write	^t AVWH	10	_	12	_	15	_	20	_	ns	
Write Pulse Width	tWLWH, tWLEH	10	_	12	_	15	_	20	_	ns	
Write Pulse Width, G High	tWLWH, tWLEH	10	_	10	_	12	_	15	_	ns	4
Data Valid to End of Write	^t DVWH	6	_	7	_	8	_	10	_	ns	
Data Hold Time	tWHDX	0	_	0	_	0	_	0	_	ns	
Write Low to Output High–Z	tWLQZ	_	6	_	7	_	8	_	10	ns	5,6,7
Write High to Output Active	tWHQX	2	_	2	_	2	_	2	_	ns	5,6,7
Write Recovery Time	tWHAX	0	_	0	_	0	_	0	_	ns	

NOTES:

- 1. A write occurs during the overlap of E low and W low.
- 2. If G goes low coincident with or after W goes low, the output will remain in a high impedance state.
- 3. All timings are referenced from the last valid address to the first transitioning address.
- 4. If $G \geq V_{\mbox{\footnotesize{IH}}},$ the output will remain in a high impedance state.
- 5. At any given voltage and temperature, t_{WLQZ} (max) is less than t_{WHQX} (min), both for a given device and from device to device.
 6. Transition is measured ±500 mV from steady–state voltage.
- 7. This parameter is sampled and not 100% tested.

WRITE CYCLE 1 (W Controlled, See Notes 1 and 2)



MOTOROLA FAST SRAM **MCM6206BB** 5

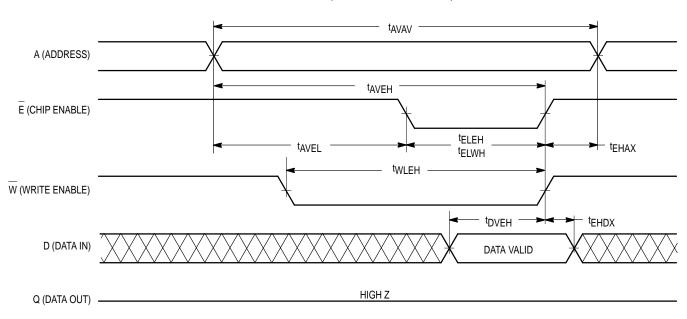
WRITE CYCLE 2 (E Controlled, See Note 1)

		-	12		15	- 2	20	- 2	25		
Parameter	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	Notes
Write Cycle Time	t _{AVAV}	12	_	15	_	20	_	25	_	ns	
Address Setup Time	^t AVEL	0	_	0	_	0	_	0	_	ns	
Address Valid to End of Write	^t AVEH	10	_	12	_	15	_	20	_	ns	
Enable to End of Write	tELEH, tELWH	9	_	10	_	12	_	15	_	ns	3,4
Data Valid to End of Write	^t DVEH	6	_	7	_	8	_	10	_	ns	
Data Hold Time	^t EHDX	0	_	0	_	0	_	0	_	ns	
Write Recovery Time	^t EHAX	0	_	0		0	_	0	_	ns	

NOTES:

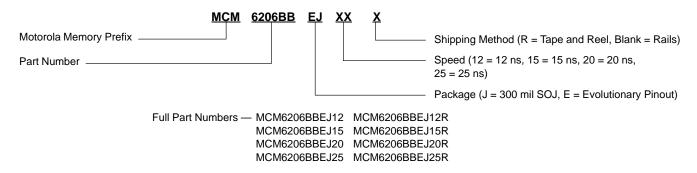
- 1. A write occurs during the overlap of ${\sf E}$ low and ${\sf W}$ low.
- All timings are referenced from the last valid address to the first transitioning address.
 If E goes low coincident with or after W goes low, the output will remain in a high impedance state.
- 4. If E goes high coincident with or before W goes high, the output will remain in a high impedance state.

WRITE CYCLE 2 (E Controlled, See Note 1)



MOTOROLA FAST SRAM **MCM6206BB**

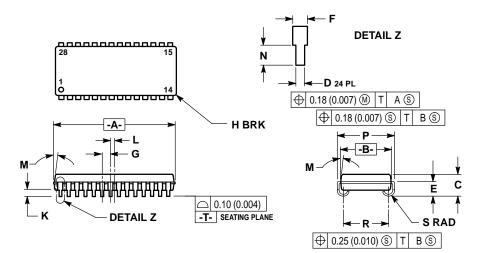
ORDERING INFORMATION (Order by Full Part Number)



MOTOROLA FAST SRAM MCM6206BB

PACKAGE DIMENSIONS

CASE 810B-03 300 MIL SOJ 28 LEAD



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- DIMENSION A & B DO NOT INCLUDE MOLD PROTRUSION. MOLD PROTRUSION SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
- 3. CONTROLLING DIMENSION: INCH.
- 4. DIM R TO BE DETERMINED AT DATUM -T-.

	INC	HES	MILLIN	METERS
DIM	MIN	MAX	MIN	MAX
Α	0.720	0.730	18.29	18.54
В	0.295	0.305	7.50	7.74
С	0.128	0.148	3.26	3.75
D	0.015	0.020	0.39	0.50
E	0.088	0.098	2.24	2.48
F	0.026	0.032	0.67	0.81
G	0.050	BSC	1.27	BSC
Н	_	0.020	_	0.50
K	0.035	0.045	0.89	1.14
L	0.025	BSC	0.64	BSC
M	0°	10°	0°	10°
N	0.030	0.045	0.76	1.14
P	0.330	0.340	8.38	8.64
R	0.260	0.270	6.60	6.86
S	0.030	0.040	0.77	1.01

Motorola reserves the right to make changes without further notice to any products herein. Motorola makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Motorola assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters which may be provided in Motorola data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Motorola does not convey any license under its patent rights nor the rights or the rights or others. Motorola products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Motorola product could create a situation where personal injury or death may occur. Should Buyer purchase or use Motorola products for any such unintended or unauthorized application, Buyer shall indemnify and hold Motorola and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Motorola was negligent regarding the design or manufacture of the part. Motorola and was registered trademarks of Motorola, Inc. is an Equal Opportunity/Affirmative Action Employer.

How to reach us:

USA/EUROPE/Locations Not Listed: Motorola Literature Distribution; P.O. Box 5405, Denver, Colorado 80217. 303–675–2140 or 1–800–441–2447

Mfax™: RMFAX0@email.sps.mot.com - TOUCHTONE 602-244-6609 - US & Canada ONLY 1-800-774-1848

JAPAN: Nippon Motorola Ltd.: SPD, Strategic Planning Office, 4–32–1, Nishi-Gotanda, Shinagawa-ku, Tokyo 141, Japan. 81–3–5487–8488

ASIA/PACIFIC: Motorola Semiconductors H.K. Ltd.; 8B Tai Ping Industrial Park, 51 Ting Kok Road, Tai Po, N.T., Hong Kong. 852–26629298

Mfax is a trademark of Motorola, Inc.

INTERNET: http://motorola.com/sps



MCM6206BB/D